JUL 1	5 2003 6	
CHIENT & TH	Substitute (Modified)	Forn





Sheet <u>1</u> of <u>1</u>

n PTO-1449

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 05542-149004

Application No. 09/863,118

**Information Disclosure Statement by Applicant** (Use several sheets if necessary)

Applicant Manoocher Birang, et al.

Filing Date

Group Art Unit

(37 CFR §1.98(b))

May 22, 2001

3723

U.S. Patent Documents								
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Cla	\$s	Subclas	Filing Date s If Appropriate
LL	, AA	5,196,353	03/23/93	Sandhu et al.				
	AB	5,257,478	11/02/93	Hyde et al.				
7	AC	5,672,091	09/30/97	Takahashi et al.				
	AD	5,949,927	09/07/99	Tang				
	AE	6,524,164	02/25/03	Tolles				
	AF	6,537,133	03/25/03	Birang et al.				
	AG	,						
	AH							
	AI		t					
	AJ							

	Foreign Patent Documents or Published Foreign Patent Applications								
Examiner		Desig.	Document	Publication	Country or			Translation	
	gitial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	71	AK	JP 62190726	08/87	JP			Abstract	
1	ľ	AL	JP 62211927	09/87	JP			Abstract	
	1	AM	JP 2222533	09/90	JP			Abstract	
		AN	JP 5138531	06/93	JP .			Abstract	
		AO	FR 1075634	10/54	FR			Х	

1	Other D	ocuments (include Author, Title, Date, and Place of Publication)			
Examine	r Desig.				
Initial	ID di	Document			
iļi	) AP	Anonymous, "Endpoint Detection of Oxide Polishing and Planarization of Semiconductor Devices, Research Disclosure No. 340, Kenneth Mason Publication, Ltd., August 1992			
	AQ	Rodel, "Glass Polishing Pad", January 1993			
	AR				
	AS				

	1						
Examiner Signature	1	Date Considered		. \			
Examiner digitatore	W 1	Date considered		\ <b>1</b> \			
YAII	1 1 GVV		1,11	1 (1 )			
11/1/	1 72 1/	Y.	1 かし	I II J			
_ \	1/1/2	Δ_	1	<u> </u>			
EXAMINER: Initials citation considered Draw line through citation if not in conformance and not considered. Include copy of this form with							
next communication to applicant.	_		1				

Substitute Disclosure Form (PTO-1449)